

## 54F174 Flip-Flop

Hex D Flip-Flops

Product Specification

Military Logic Products

### FEATURES

- Six edge-triggered D-type flip-flops
- Buffered common Clock
- Buffered, asynchronous Master Reset

### DESCRIPTION

The 54F174 has six edge-triggered flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) and Master Reset (MR) inputs load and reset (clear) all flip-flops simultaneously.

The register is fully edge-triggered. The state of each D input, one set-up time before the Low-to-High clock transition is transferred to the corresponding flip-flop's Q output.

All outputs will be forced LOW independent of Clock or Data inputs by a Low voltage level on the MR input. The device is useful for applications where true outputs only are required, and the Clock and Master Reset are common to all storage elements.

### ORDERING INFORMATION

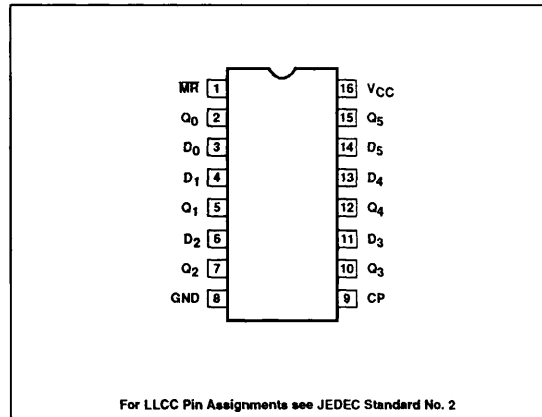
| DESCRIPTION       | ORDER CODE |
|-------------------|------------|
| Ceramic DIP       | 54F174/BEA |
| Ceramic Flat Pack | 54F174/BFA |
| Ceramic LLCC      | 54F174/B2A |

### INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

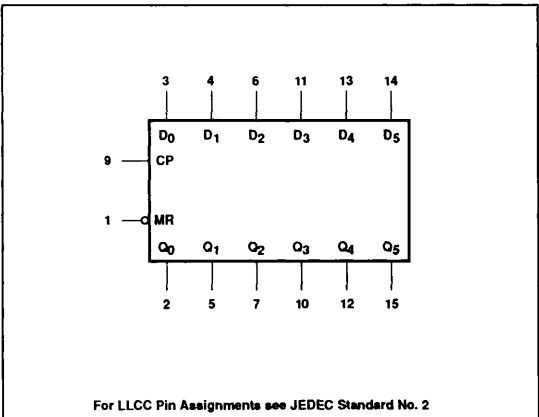
| PINS                            | DESCRIPTION                             | 54F (U.L.) HIGH/LOW | LOAD VALUE HIGH/LOW |
|---------------------------------|---|---------------------|---------------------|
| D <sub>0</sub> - D <sub>5</sub> | Data inputs                             | 1.0/1.0             | 20μA/0.6mA          |
| CP                              | Clock pulse inputs (active rising edge) | 1.0/1.0             | 20μA/0.6mA          |
| MR                              | Master Reset input (active Low)         | 1.0/5               | 20μA/0.6mA          |
| Q <sub>0</sub> - Q <sub>5</sub> | Data outputs                            | 50/33               | 1.0mA/20mA          |

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as: 20μA in the High state and 0.6mA in the Low state.

### PIN CONFIGURATION



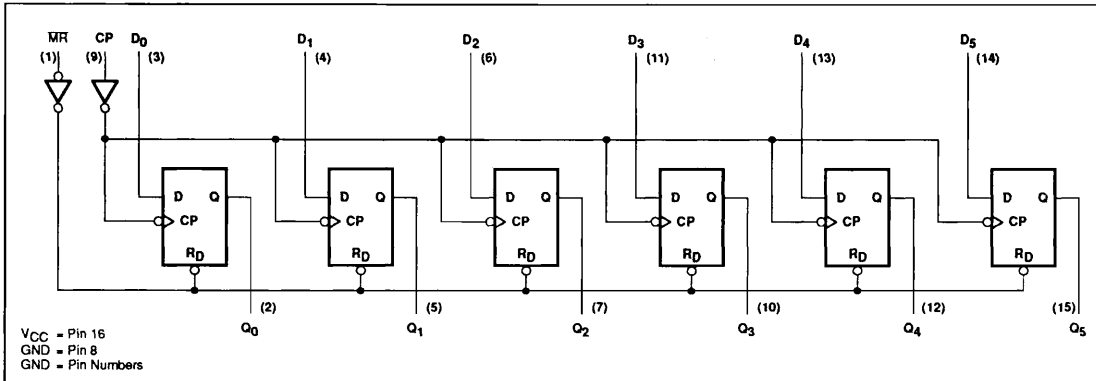
### LOGIC SYMBOL



# Flip-Flop

54F174

## LOGIC DIAGRAM



## FUNCTION TABLE

| OPERATING MODE | INPUTS |    |       | OUTPUTS |
|----------------|--------|----|-------|---------|
|                | MR     | CP | $D_n$ | $Q_n$   |
| Reset (clear)  | L      | X  | X     | L       |
| Load "1"       | H      | ↑  | h     | H       |
| Load "0"       | H      | ↑  | l     | L       |

H = High voltage level steady state.  
 h = High voltage level one setup time prior to the Low-to-High Clock transition.  
 L = Low voltage level steady state.  
 l = Low voltage level one setup time prior to the Low-to-High Clock transition.  
 X = Don't Care.  
 ↑ = Low-to-High Clock transition.

## ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

| SYMBOL    | PARAMETER  | RATING             | UNIT |
|-----------|--|--------------------|------|
| $V_{CC}$  | Supply voltage range                                 | -0.5 to +7.0       | V    |
| $V_I$     | Input voltage range                                  | -0.5 to +7.0       | V    |
| $I_I$     | Input current range                                  | -30 to +5.0        | mA   |
| $V_O$     | Voltage applied to output in High output state range | -0.5 to + $V_{CC}$ | V    |
| $I_O$     | Current applied to output in Low output state        | 40                 | mA   |
| $T_{STG}$ | Storage temperature range                            | -65 to +150        | °C   |

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL   | PARAMETER                            | LIMITS |     |      | UNIT |
|----------|--------------------------------------|--------|-----|------|------|
|          |                                      | Min    | Nom | Max  |      |
| $V_{CC}$ | Supply voltage                       | 4.5    | 5.0 | 5.5  | V    |
| $V_{IH}$ | High-level input voltage             | 2.0    |     |      | V    |
| $V_{IL}$ | Low-level input voltage              |        |     | +0.8 | V    |
| $I_{IK}$ | Input clamp current                  |        |     | -18  | mA   |
| $I_{OH}$ | High-level output current            |        |     | -1.0 | mA   |
| $I_{OL}$ | Low-level output current             |        |     | 20   | mA   |
| $T_A$    | Operating free-air temperature range | -55    |     | +125 | °C   |

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### DC ELECTRICAL CHARACTERISTICS (Over recommended operating free-air temperature range unless otherwise noted.)

| SYMBOL           | PARAMETER                                 | TEST CONDITIONS <sup>1</sup>  | LIMITS |                  |      | UNIT |
|------------------|---|---|--------|------------------|------|------|
|                  |   |   | Min    | Typ <sup>2</sup> | Max  |      |
| V <sub>OH</sub>  | High-level output voltage                 | V <sub>CC</sub> = Min, V <sub>IH</sub> = Min, I <sub>OH</sub> = Max | 2.5    |                  |      | V    |
| V <sub>OL</sub>  | Low-level output voltage                  | V <sub>CC</sub> = Min, V <sub>IL</sub> = Max, I <sub>OL</sub> = Max |        | 0.35             | 0.50 | V    |
| V <sub>IK</sub>  | Input clamp voltage                       | V <sub>CC</sub> = Min, I <sub>I</sub> = I <sub>IK</sub>             |        | -0.73            | -1.2 | V    |
| I <sub>IH2</sub> | Input current at maximum input voltage    | V <sub>CC</sub> = Max, V <sub>I</sub> = 7.0V                        |        |                  | 100  | μA   |
| I <sub>IH1</sub> | High-level input current                  | V <sub>CC</sub> = Max, V <sub>I</sub> = 2.7V                        |        | 1                | 20   | μA   |
| I <sub>IL</sub>  | Low-level input current                   | V <sub>CC</sub> = Max, V <sub>I</sub> = 0.5V                        |        | -0.4             | -0.6 | mA   |
| I <sub>OS</sub>  | Short-circuit output current <sup>3</sup> | V <sub>CC</sub> = Max   | -60    | -80              | -150 | mA   |
| I <sub>CC</sub>  | Supply current (total)                    | V <sub>CC</sub> = Max, D <sub>n</sub> = MR = 4.5V, CP = ↑           |        | 35               | 45   | mA   |

### AC ELECTRICAL CHARACTERISTICS (When measured in accordance with the procedures outlined in Signetics LOGIC App Note 202, "Testing and Specifying FAST Logic.")

| SYMBOL                               | PARAMETER                                 | TEST CONDITIONS | LIMITS                                       |            |             |  |             | UNIT     |
|--------------------------------------|---|-----------------|--|------------|-------------|--|-------------|----------|
|                                      |   |                 | T <sub>A</sub> = +25°C                       |            |             | T <sub>A</sub> = -55°C to +125°C             |             |          |
|                                      |   |                 | V <sub>CC</sub> = +5.0V                      |            |             | V <sub>CC</sub> = +5.0V ± 10%                |             |          |
|                                      |   |                 | C <sub>L</sub> = 50pF, R <sub>L</sub> = 500Ω |            |             | C <sub>L</sub> = 50pF, R <sub>L</sub> = 500Ω |             |          |
|                                      |   |                 | Min  | Typ        | Max         | Min  | Max         |          |
| f <sub>MAX</sub>                     | Maximum Clock frequency                   | Waveform 1      | 80   | 100        |             | 80   |             | MHz      |
| t <sub>PLH</sub><br>t <sub>PHL</sub> | Propagation delay<br>CP to Q <sub>n</sub> | Waveform 1      | 3.5<br>4.5                                   | 5.5<br>6.0 | 8.0<br>10.0 | 3.0<br>4.0                                   | 9.5<br>11.5 | ns<br>ns |
| t <sub>PHL</sub>                     | Propagation delay<br>MR to Q <sub>n</sub> | Waveform 3      | 5.0  | 8.5        | 14.0        | 4.5  | 15.5        | ns       |

**NOTES:**

1. For conditions shown as Min or Max, use the appropriate value specified under recommended operating conditions for the applicable type and function table operating mode.
2. All typical values are at V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C.
3. Not more than one output should be shorted at a time. For testing I<sub>OS</sub>, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

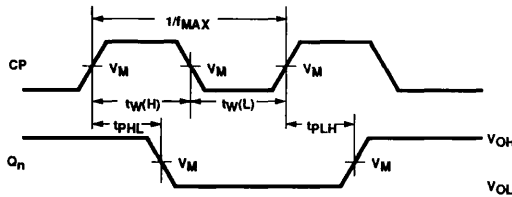
### AC SETUP REQUIREMENTS

| SYMBOL                                   | PARAMETER                                       | TEST CONDITIONS | LIMITS                                       |     |     |  |     | UNIT     |
|--|---|-----------------|--|-----|-----|--|-----|----------|
|  |   |                 | T <sub>A</sub> = +25°C                       |     |     | T <sub>A</sub> = -55°C to +125°C             |     |          |
|  |   |                 | V <sub>CC</sub> = +5.0V                      |     |     | V <sub>CC</sub> = +5.0V ± 10%                |     |          |
|  |   |                 | C <sub>L</sub> = 50pF, R <sub>L</sub> = 500Ω |     |     | C <sub>L</sub> = 50pF, R <sub>L</sub> = 500Ω |     |          |
|  |   |                 | Min  | Typ | Max | Min  | Max |          |
| t <sub>s</sub> (H)<br>t <sub>s</sub> (L) | Setup time, High or Low<br>D <sub>n</sub> to CP | Waveform 2      | 4.0<br>4.0                                   |     |     | 4.0<br>4.0                                   |     | ns<br>ns |
| t <sub>h</sub> (H)<br>t <sub>h</sub> (L) | Hold time, High or Low<br>D <sub>n</sub> to CP  | Waveform 2      | 0<br>0                                       |     |     | 0<br>0                                       |     | ns<br>ns |
| t <sub>w</sub> (H)<br>t <sub>w</sub> (L) | CP pulse width,<br>High or Low                  | Waveform 1      | 4.0<br>6.0                                   |     |     | 4.0<br>6.0                                   |     | ns<br>ns |
| t <sub>w</sub> (L)                       | MR pulse width Low                              | Waveform 3      | 5.0  |     |     | 5.0  |     | ns       |
| t <sub>rec</sub>                         | Recovery time<br>MR to CP                       | Waveform 3      | 5.0  |     |     | 6.0  |     | ns       |

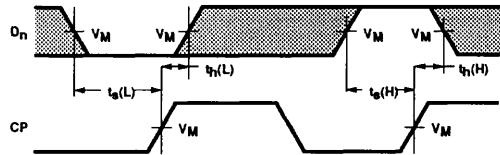
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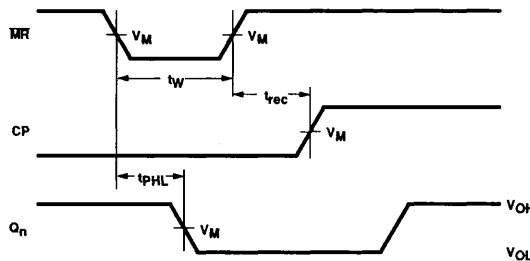
## AC WAVEFORMS



Waveform 1. Clock to Output Delays, Clock Pulse Width, and Maximum Clock Frequency



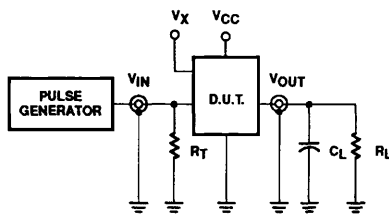
Waveform 2. Data Setup and Hold Times



Waveform 3. Master Reset Pulse Width, Master Reset to Output Delay and Master Reset to Clock Recovery Time

NOTE: For all waveforms  $V_M = 1.5V$   
The shaded areas indicate when the input is permitted to change for predictable output performance.

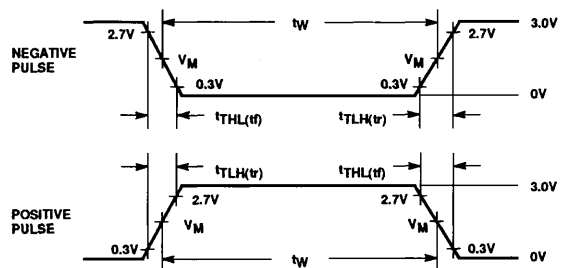
## TEST CIRCUIT AND WAVEFORM



Test Circuit for Totem-Pole Outputs

### DEFINITIONS:

- $R_L$  = Load Resistor; see AC Characteristics for value.
- $C_L$  = Load capacitance includes jig and probe capacitance; see AC Characteristics for value.
- $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.
- $V_X$  = Unlocked pins must be held at:  $\leq 0.8V$ ;  $\geq 2.7V$  or open per Function Table.



$V_M = 1.5V$

Input Pulse Definition

| INPUT PULSE CHARACTERISTICS |           |             |              |              |
|-----------------------------|-----------|-------------|--------------|--------------|
| Family                      | Rep. Rate | Pulse Width | $t_{TLH}$    | $t_{THL}$    |
| 54F                         | 1MHz      | 500ns       | $\leq 2.5ns$ | $\leq 2.5ns$ |